Near-infrared Subwavelength Imaging and Focusing Analysis of a Square Lattice Photonic Crystal Made from Partitioned Cylinders

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(Received March 12, 2013 : revised May 9, 2013 : accepted May 27, 2013)

We study the focusing properties of a two-dimensional square-lattice photonic crystal (PC) comprising silica and germanium partitioned cylinders in air background. The finite difference time domain (FDTD) method with periodic boundary condition is utilized to calculate the dispersion band diagram and the FDTD method incorporating the perfectly matched layer boundary condition is employed to simulate the image formation. In contrast to the common square PCs in which the negative refraction effect occurs in the first photonic band without negative phase propagation, in our suggested model system, the frequency with negative refraction exists in the second band and in near-infrared region. In this case, the wave propagates with a negative phase velocity and the evanescent waves can be supported. We also discuss the dependency of the image resolution and its location on surface termination, source location, and slab thickness. According to the simulation results, spatial resolution of the proposed PC lens is below the radiation wavelength.

Keywords : Photonic crystal, Negative refractive index, Super-lensing, Sub-wavelength imaging

OCIS codes : (100.6640) Super resolution; (230.5298) Photonic crystals; (130.3120) Integrated optics devices; (260.2110) Electromagnetic optics; (060.4510) Optical communications

I. INTRODUCTION

In 1968 Veselago proposed that simultaneously negative permeability and permittivity in an isotropic material leads to negative refractive index. According to this fact that the pointing vector and wave vector in these materials are in opposite directions, he called them left-handed materials (LHMs) or negative index materials (NIMs) [1]. As an electromagnetic (EM) wave passes the border between a medium with positive refractive index and a LHM, the beam of light would be refracted to the same side of the normal line as the incident beam. Since no natural material with this specification has been discovered, in the last decade, manufactured structures with negative refractive index have attracted a lot of attention due to their wonderful optical properties [2, 3] and imaging capabilities [4]. Such meta-materials are able to store both the phase of propagating waves and amplitude of evanescent waves to make perfect lenses which can overcome the diffraction limit of conventional convex lenses and introduce a new class of imaging systems called “super lenses” [4].

There are several approaches to realize the negative refraction phenomena. Some meta-materials are made from arrays of metallic split-ring resonators with metallic wire strips. Negative index of refraction in these structures appears in the microwave frequency regime [5-7]. In the optical range of frequency, different designs [8] such as double-plate (or double-wire) pairs, which provide the negative magnetic permeability, and long metal wires [9], are proposed. Another human-made structure is made from arrays of lossless dielectric media named photonic crystals (PCs). These structures are able to explore the effective negative index of refraction in the infrared and optical frequencies. In contrast to the conventional lenses in which imaging effects obey the Newton’s formula, in PCs the imaging is related to mirror-inversion transformation like mirrors although PCs produce real images [10]. Furthermore, there is no need to form a curved surface to obtain an image and also we can attain sub-wavelength imaging which

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FIG. 1. 2D square lattice PC embracing partitioned cylinders with lattice constant $a$. Darker parts of cylinders indicate SiO$_2$ and the bright parts represent Ge.

In these regards, extensive theoretical and experimental imaging studies have been performed [11-14]. Some of the studies on negative refractive index are related to 2D triangular, hexagonal and honeycomb high symmetry lattices in the second band which can be realized as left handed behavior [15-17]. Another kind of research has concentrated on 2D square lattices in which the negative refraction effect occurs in the region of the first photonic band where an isotropic negative index cannot be defined and negative refraction can be conceived by anisotropy or higher-order Bragg scattering effects [18-20]. Focusing properties of 2D square lattice PCs in the second photonic band have been studied experimentally in the range of microwave frequencies [21]. Although negative refraction phenomena in 2D square lattices have been studied extensively, it is of significance to improve efficiency of the superlensing effect especially in near-infrared frequencies.

In this paper, for evaluation of the negative refraction effect in near-infrared frequency regime in the second photonic band of 2D square lattice PCs, where the wave has a negative phase velocity and PC structure can be assumed as a LHM, we proposed a PC comprising partitioned cylinders. We show that the image position is dependent on the source location and the slab thickness. We employ the finite difference time domain (FDTD) method with periodic boundary condition for calculating the dispersion band diagram of the PC and FDTD method incorporating the perfectly matched layer (PML) boundary condition for simulating the field pattern of the point sources and their images.

II. BAND STRUCTURE PROPERTIES

The PC proposed here is a novel 2D square lattice consisting of periodic arrays of infinitely long dielectric partitioned rods of silica and germanium in air background as depicted in Fig. 1. It is assumed that the width of the slab in the $x$ direction is limited and in the $y$ direction is unrestricted. Dielectric constants of the two substances are $\varepsilon_{\text{silica}}=2.1$ and $\varepsilon_{\text{Ge}}=18$ at the wavelength of 1.55 µm and the radius of dielectric cylinders is $R=0.45a$, where $a$ is the lattice constant. We fix the lattice constant at 388 nm which provides the imaging effect at near-infrared frequency regime. According to the configuration of arrays, the TM polarized EM wave is considered for calculating the band structure of the PC and simulating the propagation of the wave in the media.

We employ the FDTD method based on Yee’s lattice to solve the Maxwell’s equations within the unit cell in the time domain by applying the periodic boundary conditions to obtain the band diagram of the PC. We identify the eigenmodes as the spectral peaks from the Fourier transform of the TM mode of the electric field in the time domain. Fig. 2 shows the calculated TM-polarized band diagram along the high-symmetry lines in the first Brillouin zone.

FIG. 2. Photonic band structure of (a) the common square lattice PC consisting of Ge cylinders in air with radius $R=0.45a$, and (b) corresponding structure composed of partitioned Ge and SiO$_2$ cylinders with the same radius. The lines originated from $\Gamma$ point depict the light lines in vacuum. Inset: the constant frequency counter of second band related to A and B points.
Fig. 2(a) displays the band diagram of common 2D square lattice PC consisting of Ge cylinders with radius of \( R = 0.45a \) and Fig. 2(b) depicts the band diagram of partitioned cylinders made from SiO\(_2\) and Ge cylinders with the same radii. By comparing these two plots we notice that partitioned cylinders create a complete band gap between second and third bands whereas there is no band gap among the first five bands for TM mode in the already mentioned common square lattice. It should be noted that the first five energy bands of the PC made from SiO\(_2\) cylinders, regarding the low dielectric constant of this material, is extended to the frequency of \( 1.1(2\pi c/a) \) and so, it is not suitable for PC superlens application.

To obtain the frequency with the negative refractive effect we should pay attention to some important conditions. First of all, the frequency should be below \( 0.5 \times 2\pi c/a \) to avoid diffraction and second, the equifrequency surface (EFS) of the PC around the \( \Gamma \) point should have an inward gradient leading to negative group velocity and the last one, the PC's EFS should contain the EFS of the background [18]. We choose the frequency of the intersection point of PC and air band diagrams to evaluate the imaging properties of this structure. The intersection normalized frequency, \( \omega a/2\pi c \), is around 0.255 and as it is apparent from Fig. 2(b), there is an inward gradient around the \( \Gamma \) point. The inset in Fig. 2(b) implies the constant frequency contour with two equal energy surfaces that is related to the second band for \( \omega a = 0.255 \). In fact, the contour approximately looks like a circle and it means that for this frequency the PC can be roughly regarded as an isotropic medium [15].

### III. Surface Termination Effect on Image Quality of the Proposed Structure

There is a type of bound photon mode in photonic crystals that is guided by the background/PC interface. This mode is the linear combination of surface states, those which are strongly affected by the position of surface termination. By coupling incident evanescent waves and bound photon modes, evanescent waves can be transmitted through the PC structure and contribute to image formation [18]. In this regard, some analysis has clarified that surface termination has a significant effect on transmission and image quality [22, 23]. According to this issue, we consider a 4.9a-thick slab and put the point source operating at a normalized frequency of 0.255 at distance \( a \) from the left side of the PC structure to examine the effect of the air/PC interface on image quality.

Figure 3 shows the electric field pattern of the point

FIG. 3. Electric field distribution of a point source located at the distance \( a \) from the left of the PC slab and at normalized frequency of 0.255 when the interface layer at both sides of the slab consists of (a) cylinders with radius \( R = 0.45a \), (b) half cylinders with \( R = 0.45a \), (c) cylinders with \( R = 0.2a \) and (d) half cylinders with \( R = 0.2a \).
source and its image when the outmost layers include (a) cylinders with radius $R=0.45a$, (b) half cylinders with radius $R=0.45a$, (c) cylinders with radius $R=0.2a$ and (d) half cylinders with radius $R=0.2a$. It can be inferred that the intensity of transmitted TM-polarized EM wave in the near field region increases with reducing the radius of the outmost cylinders. The surface termination with cylinders of radius $0.2a$ acts as an anti-reflector to decrease the reflectance. On the other hand, cutting the outmost cylinders leads to participation of the evanescent waves in image formation and improvement of the light intensity at the image site. For the half cylinders with the radius of $0.2a$ at the interface of air/PC, the evanescent waves are supported and as a result we can find higher resolution and smaller FWHM at the image site. This improvement is also verified by Fig. 4 that shows the transverse distribution of electric field intensity for different surface terminations. By considering this fact, hereafter, we concentrate on the case of PC structures with the preferred surface termination (see Fig. 5).

### IV. IMAGE POSITION DEPENDENCY ON THE SLAB THICKNESS AND POINT SOURCE LOCATION

From the common focusing laws, one can realize whether the designed lens is able to act as a negative index material or not. A number of studies have shown that the overall imaging phenomena in PCs are defined by self-collimating and complex near-field wave scattering effects rather than negative effective index (e.g., see [24]). If the negative refraction mechanism overcomes other phenomena, by increasing the distance of point source from the slab and also by increasing
the slab thickness, image position should shift to a farther distance. Here, we consider a 4a-thick PC slab to examine the effect of point source location. Fig. 6 shows the electric field pattern outside and beyond the PC structure for this typical slab thickness at normalized frequency of 0.255. In this figure we shift the location of the point source from the far-field to near-field region. In this regard, we put the point source at 1.5a, a and 0.25a from the left side of the slab. When the EM wave is emitted from the point source and enters the slab, the PC focuses the EM wave and forms the image outside the slab. As we expect from the conventional imaging rules, the closer the point source, the farther the image location. By calculating the image position of the point source we realized that by moving the point source from 1.5a to 0.25a, the place of image shifts from 0.5a to 1.9a.

In Fig. 7 electric field pattern of the point source located at 0.5a from the left side of the PC structure and its image are displayed for different slab thicknesses. We choose 4a and 7a thicknesses for this purpose. As can be seen, by increasing the thickness of the slab, the position of the image shifts from 1.48a to a farther place at 3.05a, as we expect for the NIM slab lenses in which the dominant effect in image formation is negative refraction.

V. SUBWAVELENGTH IMAGING VIA THE DESIGNED PC LENS

In order to study the sub-wavelength imaging and evaluate the spatial resolution of the proposed PC lens, we consider two point sources with a given vertical separation distance from each other to observe the peaks of two images clearly and then reduce this distance till the two peaks of images in the right side of the slab become obscure. For this purpose, firstly we put point sources 0.5a away from the PC slab. In this case, they are separated from each other by 3.7a or 0.9435λ, in the vertical direction. Fig. 8 shows the electric field distribution and corresponding light intensity when the separation distance of two point sources is 3.7a. From this figure one can recognize two images clearly. Fig. 9 represents the electric field intensity of images in the yz plane for different separation distances. As can be seen, for separation distance of 3.2a, two peaks of images are still clear but when we decrease this distance to 3.1a, only one image can be recognized. Thus, according to Rayleigh criterion [25], for normalized frequency 0.225 and separation distance of 3.2a, the spatial resolution of the system can be regarded as 0.816λ, which is smaller than the incident wavelength.
VI. CONCLUSIONS

In this report, we introduced a 2D photonic crystal including partitioned cylinders made from Ge and SiO₂ to investigate the image formation characteristics in near-infrared frequency region. We found that despite the usage of the high refractive index material Ge, the band diagram of this structure opens a gap between the second and third bands and satisfies three conditions required to create a PC lens. Although existence of sharp edges in designing such a PC structure makes some difficulties in constructing partitioned cylinders, we showed that this kind of modeling has a potential of PC superlensing in near-infrared frequency with a compressed band structure. In addition, we realized that the image formation depends on the slab thickness and the point source position from the slab. We claim that the imaging effect in our proposed partitioned cylinder PC with a properly terminated surface is dominantly governed by negative refraction effect rather than channeling or near-field scattering effects and according to Rayleigh criterion, the subwavelength focusing can occur with spatial resolution of 0.816λ at the wavelength of 1.55 µm in this structure.

REFERENCES